Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/630,983	KOIKE, HIDEHARU	
Examiner	Art Unit	
Hail Nauven	2816	

SEARCHED						
Cla	ss	Subclass	D	ate	Exar	niner
32	7	551,552, 309-311, 313,318	2/1/2005		HLN.	
		319,321				
		327,328				
V		379,180				
36	1	91.1,225		1		1
25	7	355-357	7		٧	/
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Shepardize Search	2/1/2005	HLN	